

APPROVAL SHEET

MR02X(W)

±5%, ±1%

Thick Film General purpose chip resistors
Automotive compliant AEC Q-200 qualified
Anti-Sulfuration
Size 0201

RoHS 2 Compliant with exemption 7C-I Halogen free

FEATURE

- 1. Automotive grade AEC Q200 qualified with 100% CCD visual inspection
- 2. High reliability and stability 1%
- 3. Reduced size of final equipment
- 4. Suitable for high density print circuit board assembly
- 5. Higher component and equipment reliability
- 6. RoHS 2 compliant with exemption 7C-I and Halogen free products

APPLICATION

- · Mobile phone
- PDA
- Camcorders
- Palmtop computers
- Hybrid module

DESCRIPTION

The resistors are constructed in a high grade ceramic body (aluminum oxide). Internal metal electrodes are added at each end and connected by a resistive paste that is applied to the top surface of the substrate. The composition of the paste is adjusted to give the approximate resistance required and the value is trimmed to nominated value within tolerance which controlled by laser trimming of this resistive layer.

The resistive layer is covered with a protective coat. Finally, the two external end terminations are added. For ease of soldering the outer layer of these end terminations is a pure Tin.

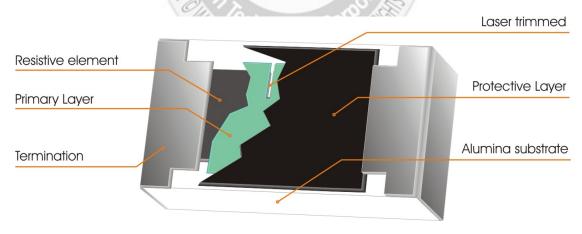


Fig 1. Construction of Chip-R



QUICK REFERENCE DATA

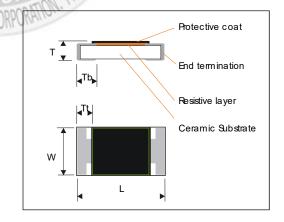
Item	General Specification		
Series No.	MR02X(W)		
Size code	020	01(0603)	
Resistance Range	1Ω~10MΩ (±5%	% tolerance), Jumper	
	1Ω~ 10ΜΩ	(±1% tolerance)	
Resistance Tolerance	±1%	±5%	
	E96+E24 E24		
TCR (ppm/°C)	1.02MΩ - 10MΩ, ≤±200ppm		
	51Ω - 1MΩ, ≤±100ppm		
	10Ω - 49.9Ω, ≤±200ppm		
	1 - 9.76Ω,	+600 ~ -200ppm	
Max. dissipation @ T _{amb} =70°C	1/20 W		
Max. Operation Voltage	25V		
Max. Overload Voltage	50V		
Operation temperature	-55 ∼ +155°C		

Note:

- 1. This is the maximum voltage that may be continuously supplied to the resistor element, see "IEC publication 60115-8"
- 2. Max. Operation Voltage : So called RCWV (Rated Continuous Working Voltage) is determined by $RCWV = \sqrt{Rated Power \times Resistance Value} \text{ or Max. RCWV listed above, whichever is lower.}$
- 3. Jumper max. 50mohm, rated current 1A, peak current 2.5A

DIMENSION(unit:mm)

	MR02X(W)
L	0.60 ± 0.03
W	0.30 ± 0.03
Т	0.23 ± 0.03
Tb	0.15 ± 0.05
Tt	0.10 ± 0.05





CATALOGUE NUMBERS

The resistors have a catalogue number starting with:

MR02	Х	472_	J	Α	L
Size code	Type code	Resistance code	Tolerance	Packaging code	Termination code
MR02:0201	X : Normal W: 1% For <10Ω / >1MΩ	5%, E24: 2 significant digits followed by no. of zeros and a blank $100\Omega = 101_$ $10K\Omega = 103_$ ("_" means a blank) $1\%, E24+E96: 3 \text{ significant digits followed by no. of zeros}$ $100\Omega = 1000$ $37.4K\Omega = 3742$	J:±5% F:±1% P:Jumper	A: 7" Reeled (15Kpcs/Reel) H: 13" Reeled (50Kpcs/Reel) G: 13" Reeled (70Kpcs/Reel)	L = Sn base (lead free)

Standard taping quantity 15,000pcs per 7" reel! 70,000pcs per 13" reel!

MARKING

MR02X(W) has no marking.



FUNCTIONAL DESCRIPTION

Product characterization

Standard values of nominal resistance are taken from the E24/E96 series for resistors with a tolerance of $\pm 5\%$ & $\pm 1\%$. The values of the E24/E96 series are in accordance with "IEC publication 60063"

Derating

The power that the resistor can dissipate depends on the operating temperature; see Fig.2

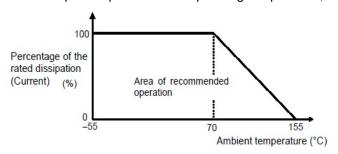


Figure 2. Maximum dissipation in percentage of rated power

As a function of the ambient temperature

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MOUNTING

Due to their rectangular shapes and small tolerances, Surface Mountable Resistors are suitable for handling by automatic placement systems.

Chip placement can be on ceramic substrates and printed-circuit boards (PCBs).

Electrical connection to the circuit is by individual soldering condition.

The end terminations guarantee a reliable contact.

Storage and Handling Conditions:

- 1. Products are recommended to be used up within two years since operation date as ensured shelf life. Check solderability in case shelf life extension is needed.
- 2. To store products with following condition:

Temperature :5 to 40°C

Humidity :20 to 70% relative humidity

- 3. Caution:
 - a. Don't store products in a corrosive environment such as sulfide, chloride gas, or acid. It may cause oxdization of electrode, which easily be resulted in poor soldering.
 - b. To store products on the shelf and avoid exposure to moisture.
- c. Don't expose products to excessive shock, vibration, direct sunlight and so on.

SOLDERING CONDITION

The robust construction of chip resistors allows them to be completely immersed in a solder bath of 260°C for 10 seconds. Therefore, it is possible to mount Surface Mount Resistors on one side of a PCB and other discrete components on the reverse (mixed PCBs).

Surface Mount Resistors are tested for solderability at 235°C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds. Typical examples of soldering processes that provide reliable joints without any damage are given in Fig 3.

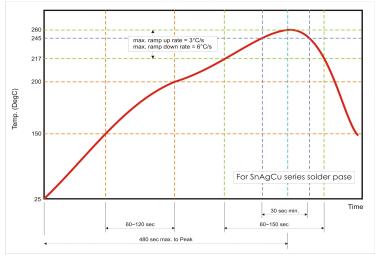


Fig 3. Infrared soldering profile for Chip Resistors SMT process with SnAgCu series solder paste



TEST AND REQUIREMENTS

The test standard condition for tests shall be in accordance with Sub-clause 4.2, JIS C 5201-1: 2011 The performance shall be satisfied in follows.

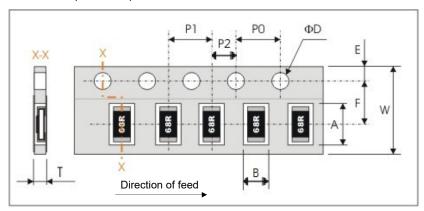
No	Test items	Condition of te	Performance requirements	
1	Resistance	Sub-clause 4.5	As in 4.5.2 The resistance value shall correspond with the rated resistance taking into account the specified tolerance Chip jumper: $50m\Omega$ max.	
2	Temperature characteristic of resistance	4.8 Natural resistance change per centigrade $\frac{R_2-R_1}{R_1(t_2-t_1)}\times 10^6$ $t_1: 20^{\circ}\text{C+5}^{\circ}\text{C-1}^{\circ}\text{C}, \ t_2: 155}^{\circ}\text{C+8}$ $R_1: \text{Resistance at reference te}$ $R_2: \text{Resistance at test tempera}$	Within the specified tolerance Refer to "QUICK REFERENCE DATA"	
3	Resistance to soldering heat	MIL-STD-202 Method 210 Test by a piece Temperature of solder bath: 27 Immersion time: 10 ±1s After immersion into solder, leatemp. for 1h or more and then resistance	ving at the room	Resistor: $\Delta R/R$: Within $\pm (0.5\% + 0.05\Omega)$ Chip jumper: $50m\Omega$ max. No evidence of appearance damage
4	Solderability	J-STD-002 a)Pre-condition: 155°C, 4h Immersion time: 5s b)Pre-condition: Steam aging, 1 Temp. of solder bath: 260°C Immersion time: 7s	The surface of terminal immersed shall be min. of 95% covered with a new coating of solder	
5	Temperature cycling	JESD22 Method JA-104 Test cycle: 1000 cycles for duty below: Step Temperature(°C) 1 -55 2 +125	r cycle as specified Time(min) 5~10 5~10	Resistor: Δ R/R: Within \pm (2%+0.05 Ω) Chip jumper: 50m Ω max. No evidence of appearance damage
6	Moisture Resistance	MIL-STD-202 Method 106 Test condition: 10 cycles for du below: A B A Temp. (°C) Rated voltage is applied. A: 90~100 B: 80~100	B B 24 %R.H. Time (h)	Resistor: $\Delta R/R$: Within $\pm (2\%+0.1\Omega)$ Chip jumper: $50 m\Omega$ max. No evidence of appearance damage



No	Test items	Condition of test			Performance requirements	
7	Operational life	MIL-STD-202 Method 108 Test temp.: 125 ±2°C Test power: 35% of rated power shall be applied for continuously Test period: 1000 +48/-0 h			Resistor: $\Delta R/R$: Within $\pm (3\%+0.1\Omega)$ Chip jumper: $50m\Omega$ max. No evidence of appearance damage	
8	Bias humidity	MIL-STD-202 Method 103 Test condition: 85°C & 85% R.H. Test power: 10% of rated power shall be applied for continuously Test period: 1000 +48/-0 h			Resistor: $\Delta R/R$: Within $\pm (3\%+0.1\Omega)$ Chip jumper: $50m\Omega$ max. No evidence of appearance damage	
9	High Temperature exposure	MIL-STD-202 Method 108 Test condition: 155 ±2°C Test period: 1000 +48/-0 h			Resistor: Δ R/R: Within \pm (3%+0.1 Ω) Chip jumper: 50 m Ω max. No evidence of appearance damage	
10	Substrate bending test	AEC-Q200- Bent value: Duration: 1	2mm(Among the fulc	rums: 90mm)	Resistor: Δ R/R: Within \pm (1%+0.05 Ω) Chip jumper: 50 m Ω max. No evidence of appearance damage	
11	Adhesion	AEC-Q200-006 Force: 3N Duration: 60s±1s			No remarkable damage or removal of the terminations	
12	Mechanical Shock	MIL-STD-202 Method 213 Peak acceleration: 1500g Peak Half sine pulse Velocity 15.4ft/sec The shock specified above shall be applied in each direction of 3 mutually perpendicular axis (3 total of 18 shocks)			The resistance value shall correspond with the rated resistance taking into account the specified tolerance No evidence of appearance damage	
13	Vibration	MIL-STD-202 Method 204 Peak acceleration: 5g's Each direction of 3 mutually perpendicular axis Test cycle: 12 Cycles			Resistor: $\Delta R/R$: Within $\pm (1\%+0.05\Omega)$ Chip jumper: $50m\Omega$ max. No evidence of appearance damage	
14	Thermal shock	MIL-STD-2	MIL-STD-202 Method 107 Test cycle: 300 cycles for duty cycle as specified		Resistor: Δ R/R: Within \pm (2%+0.1 Ω) Chip jumper: 50m Ω max. No evidence of appearance damage	
		Step	Temperature(°C)	Time(min)	1	
		1	-55	15		
		2	+125	15		
		Max transfe	er time: 20s			
15	ESD test	AEC-Q200-200 Test condition: 300V			Resistor: Δ R/R: Within \pm (1%+0.05 Ω) Chip jumper: $50m\Omega$ max. No evidence of appearance damage	
16	Hydrogen sulphide test	H2S concentration: 3ppm Test temp.: 40°C Relative humidity: 90% Test period: 1000h			Resistor: Δ R/R: Within \pm (1%+0.05 Ω) Chip jumper: $50m\Omega$ max. No evidence of appearance damage	

PACKAGING

Paper Tape specifications (unit :mm)

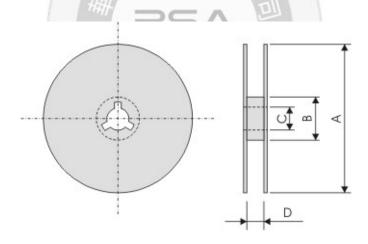


Series No.	А	В	W	F	E
MR02X	0.67±0.05	0.37±0.05	8.00±0.20	3.50±0.05	1.75±0.10

Series No.	P1	P0	P2	ΦD	Т
MR02X	2.00±0.05	4.00±0.05	2.00±0.05	Ф1.50 ^{+0.1}	0.45±0.05

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Reel dimensions



Symbol	А	В	С	D
7" Reel	Φ178.0±0.2	Φ60.0±1.0	13.0±0.2	9.0±0.5
13" Reel	Ф330.0±2.0	Φ100.0±1.0	13.0±0.2	9.0±0.5

Taping quantity and Tape material

- Chip resistors 15,000 pcs 7" Reel, Paper tape.
- Chip resistors 70,000 pcs 13" Reel, Paper tape.